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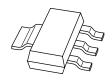
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 $\begin{array}{c} \textbf{PBSS304NZ} \\ \textbf{60 V, 5.2 A NPN low V}_{\text{CEsat}} \text{ (BISS) transistor} \\ \hline \textbf{Rev. 02-20 November 2009} \end{array}$

Product data sheet

Product profile 1.

1.1 General description

NPN low V_{CEsat} Breakthrough In Small Signal (BISS) transistor in a SOT223 (SC-73) small Surface-Mounted Device (SMD) plastic package.

PNP complement: PBSS304PZ.

1.2 Features

- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability I_C and I_{CM}
- High collector current gain (h_{FE}) at high I_C
- High efficiency due to less heat generation
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

1.3 Applications

- High-voltage DC-to-DC conversion
- High-voltage MOSFET gate driving
- High-voltage motor control
- High-voltage power switches (e.g. motors, fans)
- Automotive applications

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CEO}	collector-emitter voltage	open base	-	-	60	V
I _C	collector current		-	-	5.2	Α
I _{CM}	peak collector current	$\begin{array}{l} \text{single pulse;} \\ t_p \leq 1 \text{ ms} \end{array}$	-	-	10.4	Α
R _{CEsat}	collector-emitter saturation resistance	$I_C = 4 A;$ $I_B = 200 \text{ mA}$	[1] -	39	55	mΩ

^[1] Pulse test: $t_p \le 300 \ \mu s; \ \delta \le 0.02.$



PBSS304NZ

60 V, 5.2 A NPN low V_{CEsat} (BISS) transistor

2. Pinning information

Table 2. Pinning

Pin	Description	Simplified outline	Symbol
1	base		
2	collector	4	2, 4
3	emitter		1 —
4	collector	1 2 3	3
			sym016

3. Ordering information

Table 3. Ordering information

Type number	Package					
	Name	Description	Version			
PBSS304NZ	SC-73	plastic surface-mounted package with increased heatsink; 4 leads	SOT223			

4. Marking

Table 4. Marking codes

Type number	Marking code
PBSS304NZ	S304NZ

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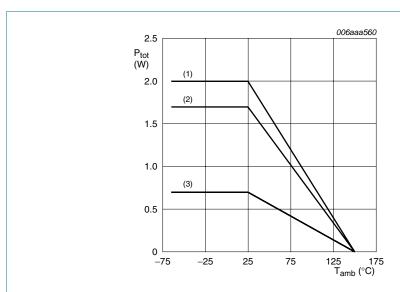
Limiting values 5.

NXP Semiconductors

Table 5. **Limiting values** In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CBO}	collector-base voltage	open emitter	-	60	V
V_{CEO}	collector-emitter voltage	open base	-	60	V
V_{EBO}	emitter-base voltage	open collector	-	5	V
I _C	collector current		-	5.2	Α
I _{CM}	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	10.4	Α
P _{tot}	total power dissipation	$T_{amb} \le 25 ^{\circ}C$	<u>[1]</u> -	0.7	W
			[2] _	1.7	W
			[3] _	2.0	W
Tj	junction temperature		-	150	°C
T _{amb}	ambient temperature		-65	+150	°C
T _{stg}	storage temperature		-65	+150	°C

- Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².
- Device mounted on a ceramic PCB, Al₂O₃, standard footprint.



- (1) Ceramic PCB, Al₂O₃, standard footprint
- (2) FR4 PCB, mounting pad for collector 6 cm²
- (3) FR4 PCB, standard footprint

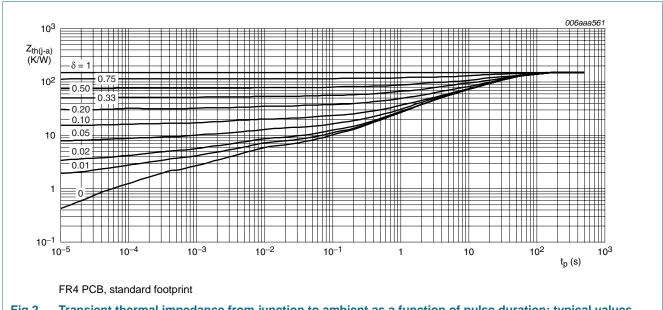
Power derating curves Fig 1.

Thermal characteristics 6.

Table 6. Thermal characteristics

Symbol	Barameter	Conditions		Min	Tvn	Max	Unit
Symbol	Parameter	Conditions		IVIIII	Тур	IVIAX	Offic
$R_{th(j-a)}$	thermal resistance from junction to ambient	<u>[2</u>	<u>[1]</u>	-	-	179	K/W
			[2]	-	-	74	K/W
			[3]	-	-	63	K/W
R _{th(j-sp)}	thermal resistance from junction to solder point			-	-	15	K/W

- Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².
- Device mounted on a ceramic PCB, Al₂O₃, standard footprint.



Transient thermal impedance from junction to ambient as a function of pulse duration; typical values Fig 2.

60 V, 5.2 A NPN low V_{CEsat} (BISS) transistor

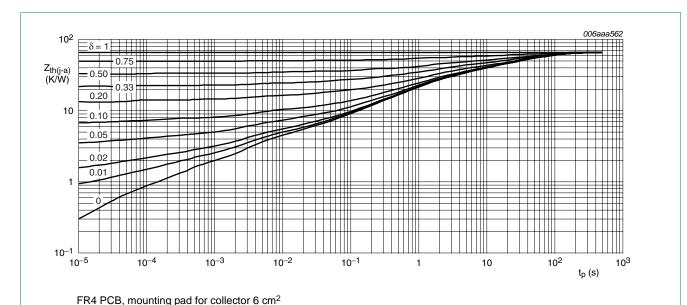


Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

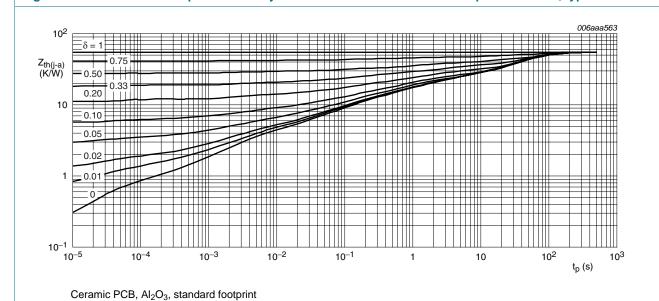


Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

60 V, 5.2 A NPN low V_{CEsat} (BISS) transistor

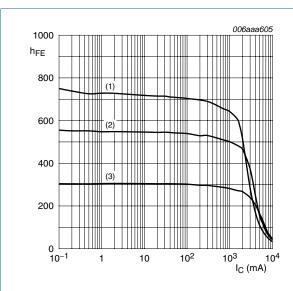
7. Characteristics

Table 7. Characteristics

 $T_{amb} = 25$ °C unless otherwise specified.

amb — 20	C unless otherwise spec	iniou.				
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I _{CBO}	collector-base cut-off	$V_{CB} = 60 \text{ V}; I_{E} = 0 \text{ A}$	-	-	100	nΑ
	current	$V_{CB} = 60 \text{ V; } I_E = 0 \text{ A;}$ $T_j = 150 \text{ °C}$	-	-	50	μΑ
I _{EBO}	emitter-base cut-off current	$V_{EB} = 5 \text{ V}; I_{C} = 0 \text{ A}$	-	-	100	nA
h _{FE}	DC current gain	$V_{CE} = 2 \text{ V}; I_{C} = 0.5 \text{ A}$	<u>[1]</u> 300	520	-	
		$V_{CE} = 2 \text{ V}; I_{C} = 1 \text{ A}$	[1] 300	500	-	
		$V_{CE} = 2 \text{ V}; I_{C} = 2 \text{ A}$	[1] 250	470	-	
		$V_{CE} = 2 \text{ V}; I_{C} = 4 \text{ A}$	^[1] 150	250	-	
		$V_{CE} = 2 \text{ V}; I_{C} = 6 \text{ A}$	<u>[1]</u> 80	120	-	
V_{CEsat}	collector-emitter	$I_C = 0.5 \text{ A}; I_B = 50 \text{ mA}$	<u>[1]</u> _	25	35	mV
	saturation voltage	$I_C = 1 A; I_B = 50 \text{ mA}$	<u>[1]</u> _	50	70	mV
		$I_C = 1 A; I_B = 10 mA$	<u>[1]</u> _	85	120	mV
		$I_C = 2 \text{ A}; I_B = 40 \text{ mA}$	<u>[1]</u> _	105	150	mV
		$I_C = 4 \text{ A}; I_B = 200 \text{ mA}$	<u>[1]</u> _	155	220	mV
		$I_C = 4 \text{ A}; I_B = 400 \text{ mA}$	<u>[1]</u> -	145	210	mV
		$I_C = 4 \text{ A}; I_B = 80 \text{ mA}$	<u>[1]</u> -	205	305	mV
		$I_C = 5.2 \text{ A}; I_B = 260 \text{ mA}$	[1] -	200	280	mV
R _{CEsat}	collector-emitter	$I_C = 4 \text{ A}; I_B = 200 \text{ mA}$	[1] -	39	55	$m\Omega$
	saturation resistance	$I_C = 4 \text{ A}; I_B = 80 \text{ mA}$	[1] -	51	76	mΩ
V_{BEsat}	base-emitter saturation	$I_C = 1 A$; $I_B = 100 \text{ mA}$	[1] -	0.82	0.9	V
	voltage	$I_C = 4 \text{ A}; I_B = 400 \text{ mA}$	[1] -	0.94	1.05	V
V_{BEon}	base-emitter turn-on voltage	$V_{CE} = 2 \text{ V}; I_{C} = 2 \text{ A}$	[1] -	0.75	0.85	V
t _d	delay time	$V_{CC} = 12.5 \text{ V}; I_C = 3 \text{ A};$	-	15	-	ns
t _r	rise time	I _{Bon} = 0.15 A;	-	95	-	ns
t _{on}	turn-on time	- I _{Boff} = −0.15 A	-	110	-	ns
t _s	storage time		-	360	-	ns
t _f	fall time		-	195	-	ns
t _{off}	turn-off time		-	555	-	ns
f _T	transition frequency	$V_{CE} = 10 \text{ V}; I_{C} = 100 \text{ mA};$ f = 100 MHz	-	130	-	MHz
C _c	collector capacitance	$V_{CB} = 10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz	-	48	70	pF

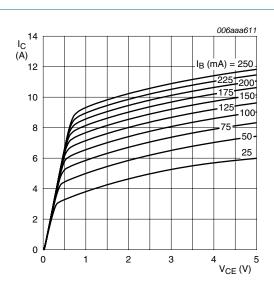
^[1] Pulse test: $t_p \le 300~\mu s;~\delta \le 0.02.$



$$V_{CE} = 2 V$$

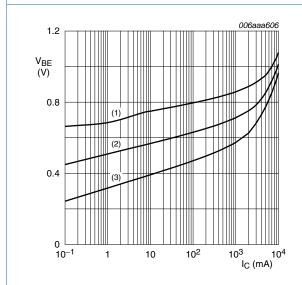
- (1) $T_{amb} = 100 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = -55 \, ^{\circ}C$

Fig 5. DC current gain as a function of collector current; typical values



T_{amb} = 25 °C

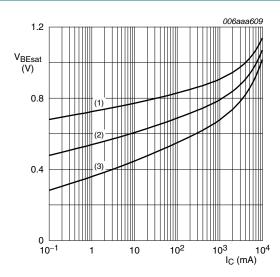
Fig 6. Collector current as a function of collector-emitter voltage; typical values





- (1) $T_{amb} = -55 \,^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) T_{amb} = 100 °C

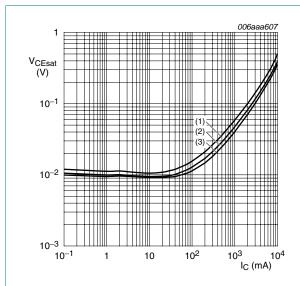
Fig 7. Base-emitter voltage as a function of collector current; typical values



$$I_{\rm C}/I_{\rm B}=20$$

- (1) $T_{amb} = -55 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = 100 \, ^{\circ}C$

Fig 8. Base-emitter saturation voltage as a function of collector current; typical values



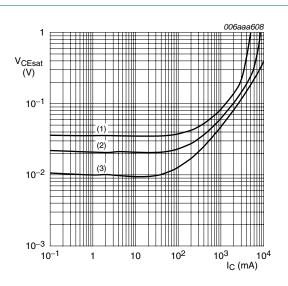
 $I_{\rm C}/I_{\rm B} = 20$

(1) $T_{amb} = 100 \, ^{\circ}C$

(2) $T_{amb} = 25 \, ^{\circ}C$

(3) $T_{amb} = -55 \, ^{\circ}C$

Fig 9. Collector-emitter saturation voltage as a function of collector current; typical values



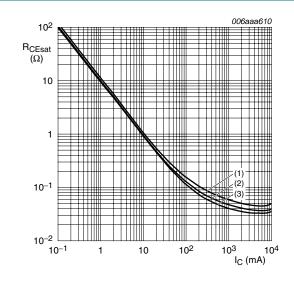
T_{amb} = 25 °C

(1) $I_C/I_B = 100$

(2) $I_C/I_B = 50$

(3) $I_C/I_B = 10$

Fig 10. Collector-emitter saturation voltage as a function of collector current; typical values



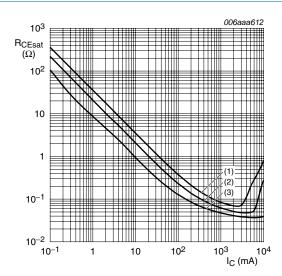
 $I_{\rm C}/I_{\rm B}=20$

(1) $T_{amb} = 100 \, ^{\circ}C$

(2) $T_{amb} = 25 \, ^{\circ}C$

(3) $T_{amb} = -55 \, ^{\circ}C$

Fig 11. Collector-emitter saturation resistance as a function of collector current; typical values



T_{amb} = 25 °C

(1) $I_C/I_B = 100$

(2) $I_C/I_B = 50$

(3) $I_C/I_B = 10$

Fig 12. Collector-emitter saturation resistance as a function of collector current; typical values

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60 V, 5.2 A NPN low V_{CEsat} (BISS) transistor

8. **Test information**

Product data sheet

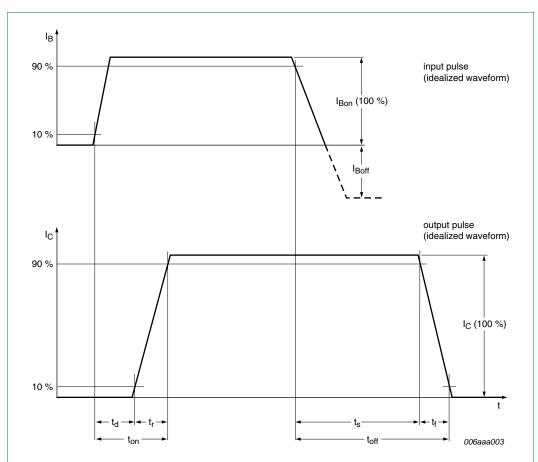
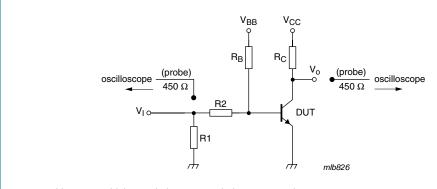


Fig 13. BISS transistor switching time definition

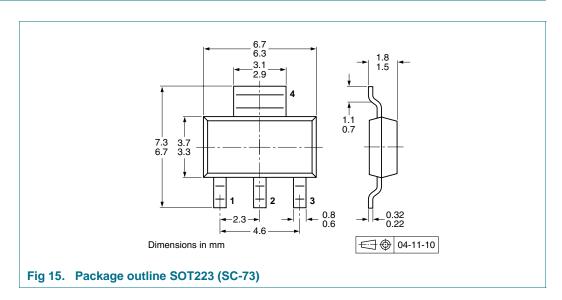


 V_{CC} = 12.5 V; I_{C} = 3 A; I_{Bon} = 0.15 A; I_{Boff} = -0.15 A

Fig 14. Test circuit for switching times

60 V, 5.2 A NPN low V_{CEsat} (BISS) transistor

9. Package outline



10. Packing information

Table 8. Packing methods

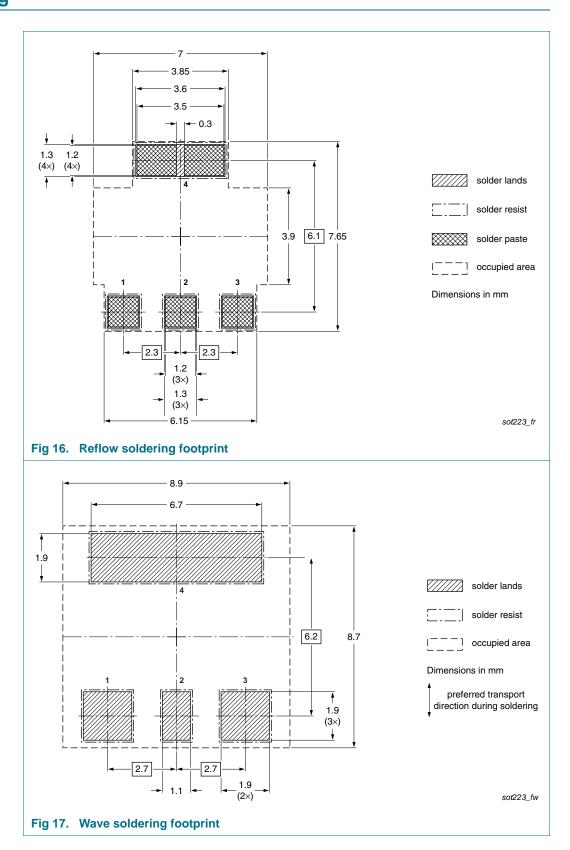
The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	Description	Packing quantity	
			1000	4000
PBSS304NZ	SOT223	8 mm pitch, 12 mm tape and reel	-115	-135

[1] For further information and the availability of packing methods, see $\underline{\text{Section 14}}$.

60 V, 5.2 A NPN low V_{CEsat} (BISS) transistor

11. Soldering





12. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSS304NZ_2	20091120	Product data sheet	-	PBSS304NZ_1
Modifications:	 This data sheet was changed to reflect the new company name including new legal definitions and disclaimers. No changes wer content. 			
	• Figure 16 "R	eflow soldering footprint": ι	ıpdated	
	Figure 17 "W	/ave soldering footprint": up	odated	
PBSS304NZ_1	20060918	Product data sheet	-	-

60 V, 5.2 A NPN low V_{CEsat} (BISS) transistor

13. Legal information

13.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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PBSS304NZ

60 V, 5.2 A NPN low V_{CEsat} (BISS) transistor

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